

**Search Notes**

Application/Control No.

10/537,174

Examiner

Son T. Nguyen

Applicant(s)/Patent under  
Reexamination

NASLUND ET AL.

Art Unit

3643

**SEARCHED**

Class	Subclass	Date	Examiner
54	44.1 44.3	8/11/2009	STN
	44.5 46.1		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
IPC foreign search and text search, see printouts.	8/11/2009	STN